



Indian Institute of Technology, Bombay

Sophisticated Analytical Instrument Facility (S.A.I.F)

Registration Form
Cryogenic Transmission Electron Microscopy (CryoEM)
Email: cryoem@ircc.iitb.ac.in

External User Registration No.: Date:

User's Name:

Institute / Organization's Name:

Email & Telephone No.:

Type of Experiment (Please select):

- Talos 120kV- Negative staining grid
- Talos 120kV- Cryo grid
- Talos 120kV- Tomography grid
- Krios 300kV- Screening
- Krios 300kV- Data acquisition

Number of samples:

Nature of samples:

Sample code:

Sample details:

Any special requirements:

Reference images of TEM/ Cryo TEM or previous data image (Compulsory for 300kV Cryo-TEM slot):

THE PROVIDED MATERIAL IS NOT HAZARDOUS OR TOXIC IN ANY FORM.

We commit to acknowledge the Cryogenic Transmission Electron Microscopy National Facility at IIT Bombay in our Publications, Reports, or Theses wherein the data is utilized, with feedback via email (cryoem@ircc.iitb.ac.in).

User's Signature:

Operator's Name:

Sample Received Date: Analysis Period:

Results Sent Date: Experiment Completion Date: